Towards a Precision Measurement of the tt Cross Section

CMS

CMS Experiment at LHC, CERN Data recorded: Wed Jul 8 19:26:24 2015 CEST Run/Event: 251244 / 83494441 Lumi section: 151 Orbit/Crossing: 39572626 / 358

MET = 164.0 GeV $Jet p_{T} = 81.6 \text{ GeV}$ $P_{T} = 56.8 \text{ GeV}$ $P_{T} = 57.7 \text{ GeV}$ $Muon p_{T} = 53.8 \text{ GeV}$

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Introduction

Why is a precision measurement of the top pair production cross section important ?

- Precision test of the SM, possible small deviations
- Pole mass extraction
- PDF/ α_s extraction



How to obtain the highest possible precision ?

- Focus on the highest systematic uncertainties
- Today: Trigger and Lepton ID/ISO





Analysis Setup

> Full **di-lepton** channel, including same flavor decays

- ≥ 2 OS tight leptons, p_T > 20 GeV, $|\eta| < 2.4, m_{e\mu} > 20$ GeV (see talk T4.3 from M. Savitskyi)
- > Jets: $p_T > 30$ GeV, $|\eta| < 2.5$

> Agreement between data and MC

Subset of data with 24.9 fb⁻¹



Trigger Efficiency

- Until now: Systematic uncertainty on the trigger efficiency determination/ scale factors one of the dominant uncertainties
 - 1.2 % Trigger uncertainty in latest measurement
- Precise determination of systematic uncertainty from comparisons of different methods
- > Use a combination of single and di-lepton triggers
 - Higher efficiency → lower statistical uncertainty (binominal statistics)



Methods: MET Monitoring Triggers

Independent monitor trigger #Events(MET Trigger+Dilep Trigger+Dilep. Sel) #Events(MET Trigger+Dilep Sel) > Pros: Per event efficiency Measured in tt phase space

Cons

>

Possible Correlations





Methods: Tag and Probe

> Two leptons in the Z-mass window

- Tag lepton: tight offline cuts + online trigger
- Probe lepton: tight offline cuts
- Passing probe: trigger to be measured
- $\epsilon = \frac{\# \text{ passing probe}}{\# \text{ failing probe}}$

> Pros

Very high statistics

> Cons

- Measures trigger efficiency in the DY phase space
- Efficiency per trigger leg





Comparison for the Single Electron Trigger Monitored with MET and Single Muon Triggers

- Comparison for the single electron trigger efficiency monitored with single muon /MET triggers
- Select eµ-pair offline
- > Agreement over a wide range of phase space
 - No global bias from MET triggers
 - Similar results for Single Muon Triggers





Comparison of Scale Factors Tag & Probe and Orthognoal Trigger Method

Compare two totally independent methods

- Efficiencies determined in DY and tt events
- Per leg vs. per event methods
- eµ dataset: impact from electron and muon triggers
 - Phase space specific
 - Trigger selection specific





Tag & Probe vs. Orthogonal Triggers: Results





Constraining Lepton ID/ISO Uncertainties

- Include same flavor channels as separate templates
- Muon uncertainties can be constrained in ee channel and vice versa
- > Z-Veto mitigates impact of DY
 - We don't measure the DY cross section



Conclusions

- I am preparing a precision measurements of the top quark pair production cross section at 13 TeV
 - Earlier measurements confirmed SM
 - Any BSM contribution would be small
- Significant improvement over earlier results is possible
 - Incremental work on systematics
 - Work on trigger and lepton uncertainties shown today







Thank you for your Attention



Fit: General Description

- > Method taken from Run I cross section measurement (CMS-PAS-TOP-13-004)
- Template fit to jet and b-jet distributions
- Templates (signal + background) taken from MC, fitted to data
 - Binned Poisson likelihood fit including nuisance parameters for systematic uncertainties λ_i
 - Binned Poisson likelihood fit: $\chi^2_{bin} = -2 \cdot \sum_{j=bjets} \ln P_{N_j(\vec{\lambda},\sigma_{t\bar{t}})}(N_j^{data}) nuis$

> Jet variables used to constrain uncertainty from b-tagging, jet energy corr.

- First divide events into three bins by number of b-jets: $N_b = 1$; $N_b = 2$; $N_b = 0$ or $N_b \ge 3$
- Then for each of these take: N_{events} for events with no additional light jet

 p_T^{lead} for events with one additional light jet $p_T^{sublead}$ for events with two additional light jets p_T^{lowest} for events with three or more additional light jets



In total 12 distributions for the fit

